SiC JFET Division

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Silicon Carbide (SiC) Combo JFET - EliteSiC, Power N-Channel, TO-247-4L, 750 V, 8.4 mohm Rev. C, January 2025

Description

Qorvo's UG4SC075009K4S "Combo-FET" integrates both a 750V SiC JFET and a Low Voltage Si MOSFET into a single TO-247-4L package. This innovative approach allows users to create circuitry that would enable a normally-off switch while leveraging the benefits of a normally-on SiC JFET. These benefits include ultra-low on-resistance (R_{DS(on)}) to minimize conduction losses and the exceptional robustness characteristic of a simplified JFET device structure, making it capable of handling the high-energy switching required in circuit protection applications. For switch-mode power conversion application, this device provides separate access to the JFET and MOSFET gates for improved speed control and ease of paralleling multiple devices.

Features

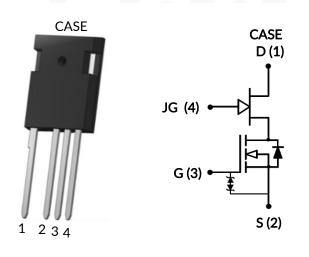
- Single digit R_{DS(on)}
- Normally-off capability
- Improved speed control
- Improved parallel device operation (3+ FETs)
- Operating temperature: 175°C (max)
- High pulse current capability
- Excellent device robustness
- Silver-sintered die attach for excellent thermal resistance
- Short circuit rated
- AECQ Qualified

Typical applications

- Solid State / Semiconductor Circuit Breaker
- Solid State / Semiconductor Relay
- Battery Disconnects
- Surge Protection
- Inrush Current Control
- High power switch mode converters (>25kW)



UG4SC075009K4S



Part Number	Package	Marking
UG4C075009K4S	TO-247-4L	UG4SC075009K4S







Maximum Ratings

Parameter	Symbol	Test Conditions	Value	Units
Drain-source voltage	V _{DS}		750V	V
JFET Gate (JG) to source voltage	V	DC	-30 to +3	V
JFET Gate (JG) to source voltage	V _{JGS}	AC ¹	-30 to +30	V
MOSFET Gate (G) to source voltage	V	DC	-20 to +20	V
MOSFET Gate (G) to source voltage	V _{GS}	AC (f > 1Hz)	-25 to +25	V
Continuous drain current ²	1	T _C < 61°C	106	А
Continuous drain current	I _D	T _C = 100°C	86	А
Pulsed drain current ³	I _{DM}	T _C = 25°C	344	А
Single pulsed avalanche energy ⁴	E _{AS}	L=15mH, I _{AS} = 5.2A	202	mJ
Power dissipation	P _{tot}	T _C = 25°C	375	W
Maximum junction temperature	T _{J,max}		175	°C
Operating and storage temperature	T _J ,T _{STG}		-55 to 175	°C
Max. lead temperature for soldering,	TL		250	°C

1. +30V AC rating applies for turn-on pulses <200ns applied with external R_G > 1 Ω .

- 2. Limited by bondwires
- 3. Pulse width t_p limited by $T_{J,max}$
- 4. Starting $T_J = 25^{\circ}C$

Thermal Characteristics

Parameter	Symbol	Test Conditions	Value			Units
			Min	Тур	Max	Units
Thermal resistance, junction-to-case	$R_{\theta JC}$			0.31	0.40	°C/W

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Electrical Characteristics (T_J = +25°C and V_{JGS} = 0V unless otherwise specified)

Typical Performance - Static

Parameter	Cumple al	Test Conditions		Value			Units			
Falameter	Symbol			Min	Тур	Max	Units			
Drain-source breakdown voltage	BV _{DS}	V _{GS} =V _{JGS} =	=0V, I _D =1mA	750			V			
	1		V, V _{GS} =0V, /, T _J =25°C		4	84				
Total drain leakage current	I _{DSS}	V _{DS} =750V, V _{GS} =0V, V _{JGS} =0V, T _J =175°C			35		μA			
Total JFET gate leakage current	I _{JGSS}	V _{JGS} =-20V, V _{GS} =+12V			0.1	65	μA			
Total MOSFET gate leakage current	I _{GSS}	V _{GS} =-20V / +20V			2	20	μA			
	R _{DS(on)}					V _{JGS} =2V T _J =25°C		8.4		
Drain-source on-resistance		V _{GS} =12V DS(on) I _D =70A	T _ا =25°C		9	11.5	mΩ			
			T_=125°C		14.8					
			T_=175°C		19.4					
JFET gate threshold voltage	$V_{JG(th)}$	$V_{DS}=5V, V_{GS}=12V,$ $I_{D}=110mA$		-11.3	-9.3	-6.7	V			
MOSFET gate threshold voltage	V _{G(th)}	$V_{DS}=5V, V_{JGS}=0V,$ $I_{D}=10mA$		3.5	4.5	5.5	V			
JFET gate resistance	R _{JG}	f=1MHz, open drain			0.8		Ω			
MOSFET gate resistance	R _G	f=1MHz,	open drain		2.3		Ω			

Typical Performance - Reverse Diode

Parameter	Symbol	Test Conditions	Value			– Units
Falameter	Symbol		Min	Тур	Max	Units
Diode continuous forward current ¹	I _S	T _C < 61°C			106	А
Diode pulse current ²	I _{S,pulse}	T _C = 25°C			344	А
Forward voltage	M	V _{GS} =0V, V _{JGS} =0V, I _S =35A, T _J =25°C		1.10	1.24	v
	V _{FSD}	V _{GS} =0V, V _{JGS} =0V, I _s =35A, T _J =175°C		1.14		
Reverse recovery charge	Q _{rr}	V_{DS} =400V, I _S =70A, V_{GS} =V _{JGS} =0V, R _{JG} =0.7 Ω		368		nC
Reverse recovery time	t _{rr}	di/dt=4400A/μs, Tj=25°C V _{DS} =400V, I _S =70A,		31		ns
Reverse recovery charge	Q _{rr}	V_{DS} =400V, I _S =70A, V_{GS} =V _{JGS} =0V, R _{JG} =0.7 Ω		433		nC
Reverse recovery time	t _{rr}	di/dt=4400A/μs, Τ _ι =150°C		35		ns





Typical Performance - Dynamic with MOSFET gate as control terminal and $V_{\text{JGS}}\text{=}0\text{V}$

Parameter	Symbol	Test Conditions	Value			Units
			Min	Тур	Max	Offics
MOSFET input capacitance	C _{iss}	V _{DS} =400V, V _{GS} =0V,		3340		
Output capacitance	C _{oss}	V _{DS} =400V, V _{GS} =0V, V _{JGS} =0V, f=100kHz		230		pF
Reverse transfer capacitance	C _{rss}			1.4		
Effective output capacitance, energy	C _{oss(er)}	V _{DS} =0V to 400V,		286		pF
Effective output capacitance, time related	C _{oss(tr)}	V _{GS} =0V, V _{JGS} =0V		605		pF
C _{OSS} stored energy	E _{oss}	V _{DS} =400V, V _{GS} =0V, V _{JGS} =0V		23		μ
Total Gate charge	Q_G	V _{DS} =400V, I _D =70A,		75		
Gate-drain charge	Q_{GD}	V _{JGS} =0V,		13		nC
Gate-source charge	Q _{GS}	V _{GS} = 0V to 15V		22		
Turn-on delay time	t _{d(on)}	Notes 5 and 6		26		
Rise time	t _r	V _{DS} =400V, I _D =70A,		21		
Turn-off delay time	t _{d(off)}	V_{GS} =0V to +15V, $R_{G ON}$ =1 Ω , $R_{G OFF}$ =10 Ω ,		112		ns
Fall time	t _f	$R_{JG_{ON}}=0.7\Omega, R_{JG_{OFF}}=4.7\Omega,$		42.5		
Turn-on energy	E _{ON}	Inductive Load, - FWD: same device with V _{GS} -		1135		
Turn-off energy	E _{OFF}	$= 0V, R_{G} = 10\Omega, V_{JGS} = 0V,$		1013		μ
Total switching energy	E _{TOTAL}	R _{JG} =0.7Ω, T _J =25°C		2148		
Turn-on delay time	t _{d(on)}	Notes 5 and 6		24		
Rise time	t _r	V _{DS} =400V, I _D =70A, V _{GS} =0V to +15V,		25		ns
Turn-off delay time	$t_{d(off)}$	$\begin{array}{c} V_{GS}=0V \text{ to } +15V, \\ R_{G_ON}=1\Omega, R_{G_OFF}=10\Omega, \\ R_{JG_ON}=0.7\Omega, R_{JG_OFF}=4.7\Omega, \\ Inductive Load, \\ FWD: same device with V_{GS} \\ = 0V, R_G = 10\Omega, V_{JGS}=0V, \\ R_{JG}=0.7\Omega, T_J=150^{\circ}C \end{array}$		114		115
Fall time	t _f			40		
Turn-on energy	E _{ON}			1170		
Turn-off energy	E _{OFF}			953		μJ
Total switching energy	E _{TOTAL}			2123		

5. Measured with the half-bridge mode switching test circuit in Figure 23.

6. Devices are driven with the ClampDRIVE method as descriped in the section "Recommended Gate Drive Approach: ClampDRIVE method".





Typical Performance - Dynamic with JFET gate as control terminal and V_{GS} =+12V

Parameter	Symbol	Test Conditions	Value			Units
	Symbol	Test conditions	Min	Тур	Max	Onits
JFET input capacitance	C _{Jiss}	V _{DS} =400V, V _{JGS} =-20V, - f=100kHz -	1965	1965		
JFET output capacitance	C _{Joss}			226		pF
JFET reverse transfer capacitance	C _{Jrss}			222		
JFET total gate charge	Q _{JG}	V _{DS} =400V, I _D =70A, V _{JGS} = -18V to 0V		304		
JFET gate-drain charge	Q _{JGD}			159		nC
JFET gate-source charge	Q _{JGS}			50		

Typical Performance Diagrams - MOSFET gate as control terminal and V_{JGS} =0V

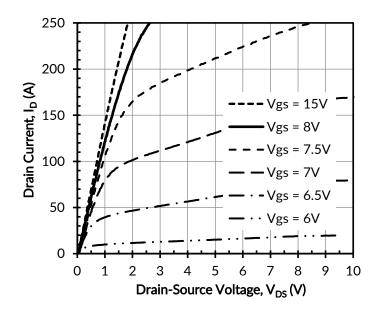


Figure 1. Typical output characteristics at T_J = - 55°C, tp < 250 μ s

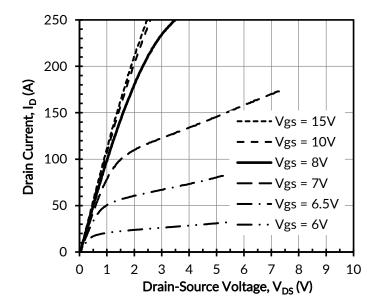
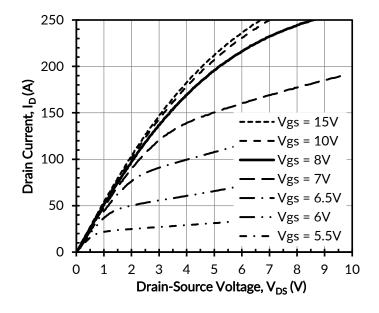
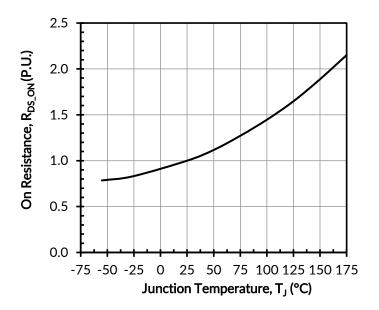


Figure 2. Typical output characteristics at $T_J = 25^{\circ}$ C, tp < 250 μ s





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Figure 3. Typical output characteristics at $T_{\rm J}$ = 175°C and tp < 250 μs

Figure 4. Normalized on-resistance vs. temperature at V_{GS} = 12V and I_{D} = 70A

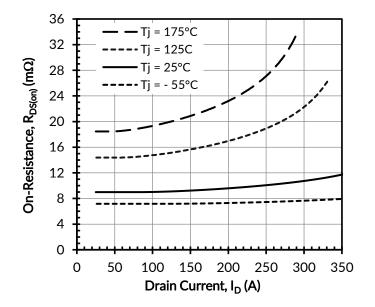


Figure 5. Typical drain-source on-resistances at V_{GS} = 12V

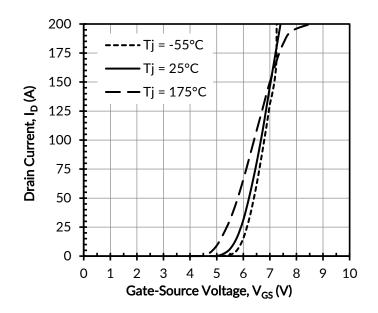


Figure 6. Typical transfer characteristics at V_{DS} = 5V

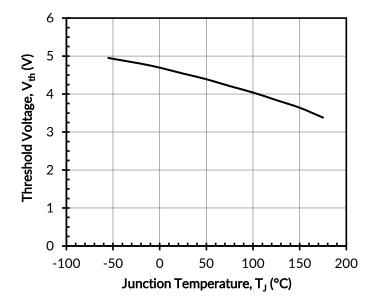
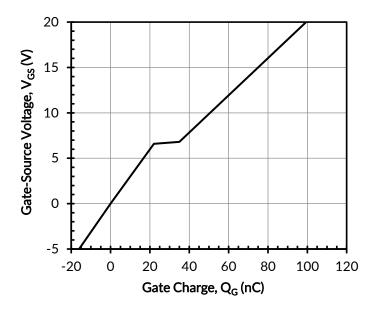


Figure 7. Threshold voltage vs. junction temperature at V_{DS} = 5V and I_D = 10mA



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Figure 8. Typical gate charge at V_{DS} =400V and I_D = 70A

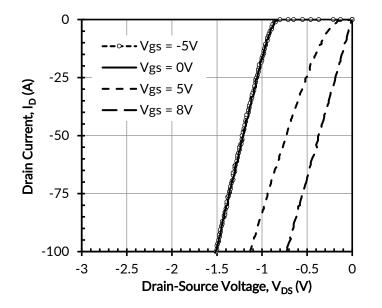


Figure 9. 3rd quadrant characteristics at $T_J = -55^{\circ}C$

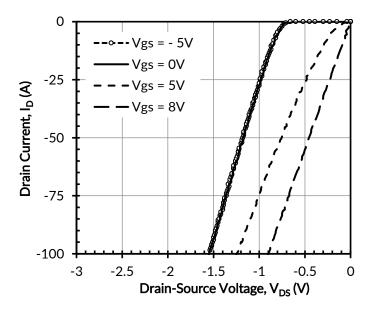
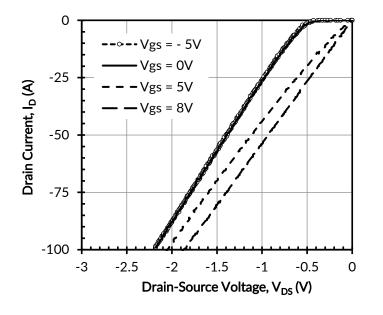
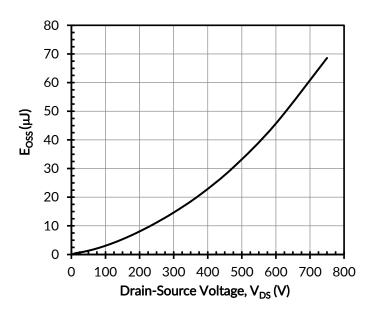


Figure 10. 3rd quadrant characteristics at $T_J = 25^{\circ}C$





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Figure 11. 3rd quadrant characteristics at $T_J = 175^{\circ}C$

Figure 12. Typical stored energy in C_{OSS} at V_{GS} = 0V

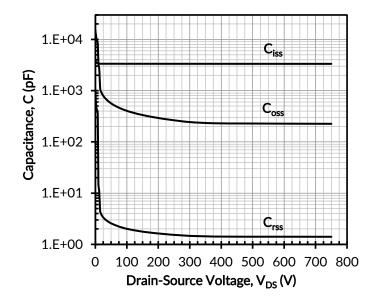


Figure 13. Typical capacitances at f = 100kHz and V_{GS} = 0V

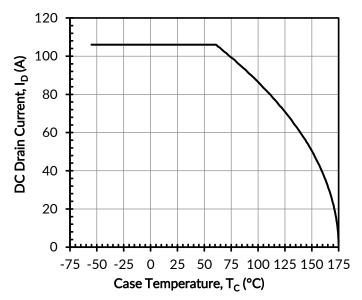


Figure 14. DC drain current derating

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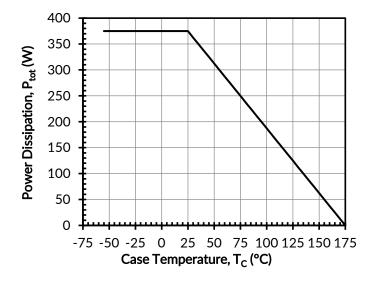
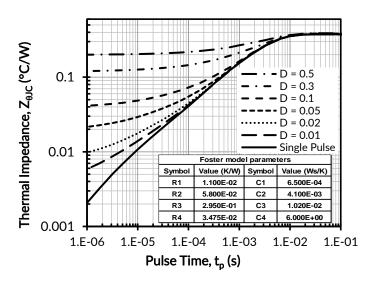


Figure 15. Total power dissipation



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Figure 16. Maximum transient thermal impedance

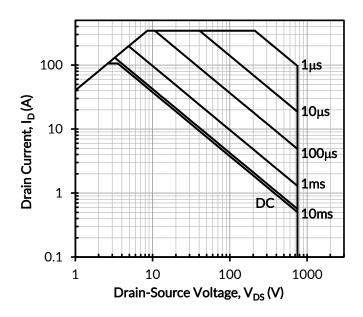


Figure 17. Safe operation area at $T_C = 25^{\circ}C$, D = 0, Parameter t_p

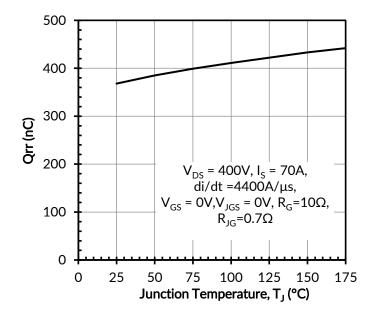


Figure 18. Reverse recovery charge Qrr vs. junction temperature

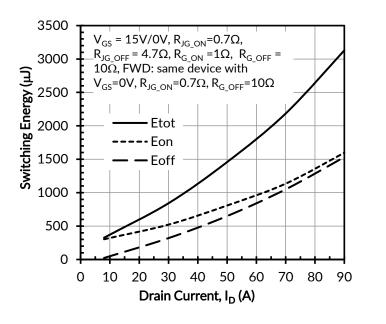


Figure 19. Clamped inductive switching energy vs. drain current at V_{DS} =400V and T_J = 25°C

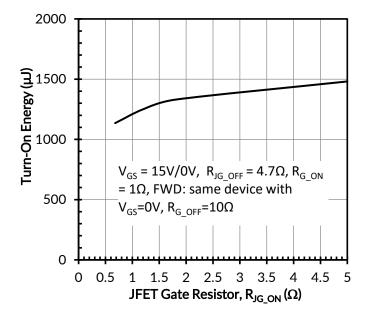
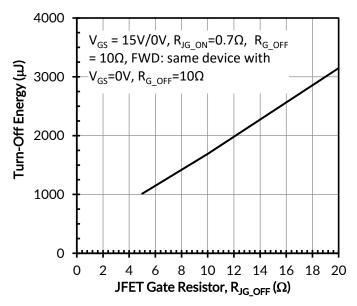


Figure 21. Clamped inductive switching energies vs. JFET gate resostor R_{JG_ON} at V_{DS} = 400V, I_D =70A, and T_J = 25°C



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Figure 20. Clamped inductive switching energies vs. JFET gate resistor R_{JG_OFF} at V_{DS} = 400V, I_D =70A, and T_J = 25°C

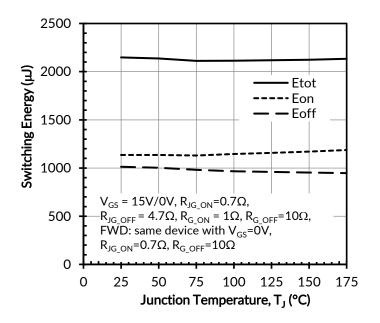
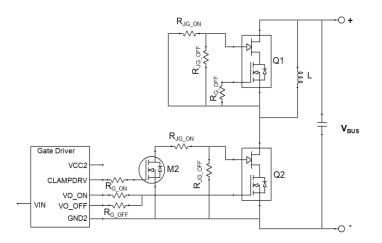
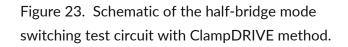


Figure 22. Clamped inductive switching energy vs. junction temperature at V_{DS} =400V and I_D =70A

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Typical Performance Diagrams - JFET gate as control terminal and V_{GS} =+12V

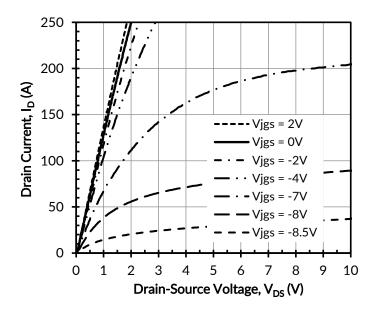


Figure 24. Typical output characteristics with JFET gate as control at T_J = - 55°C, t_p < 250 μs

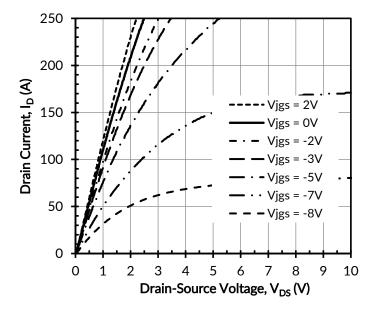
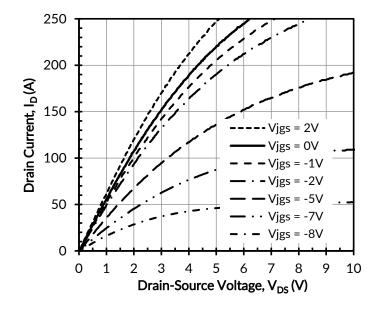
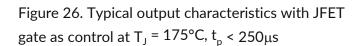


Figure 25. Typical output characteristics with JFET gate as control at T_J = 25°C, $t_{\rm p}$ < 250 μs





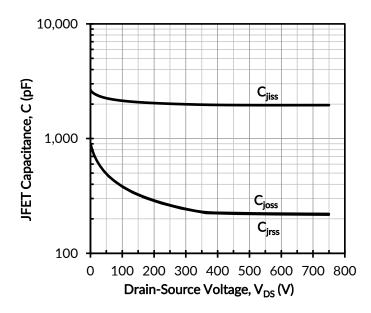
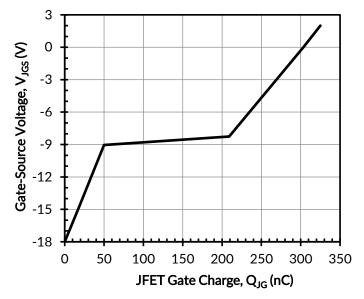


Figure 28. Typical JFET capacitances at f = 100kHz and V_{JGS} = -20V



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Figure 27. Typical JFET gate charge at V_{DS} = 400V and I_{D} = 70A





Recommended Gate Drive Approach: ClampDRIVE method

Since both JFET gate and MOSFET gate are accessible, more parameters and approaches can be used to control the switching behavior of the device and make the device suitable for a wide range applications from solid state circuit breakers requiring ultra-high current turn-off capability to motor drives requiring well controlled switching speed. The recommended gate drive approach is the ClampDRIVE method, with which the desired turn-on speed, turn-off speed and reverse recovery performance can be achieved at the same time. The main idea of this method is to dynamically tune the JFET gate resistor value R_{JG} such that, in the off-state, R_{JG} is small enough not to cause a reverse recovery issue, and during turn-off transient, R_{JG} is set to a higher value for the desired turn-off performance. This method can be easily implemented using a commercial off-the-shelf gate driver with miller clamp pre-driver output, as illustrated in Figure A. VIN is the gate driver input signal. VO is the gate driver output and CLAMPDRV is the gate driver miller clamp pre-driver output. M2 is the clamp MOSFET used to control the JFET gate resistance. The MOSFET M2 is directly controlled by the CLAMPDRV signal.

In the on-state, CLAMPDRV is low which turns the MOSFET M2 off, thus, the effective JFET gate resistance is R_{JG_OFF} . During the turn-off transient, CLAMPDRV is kept low until the device is fully off. This means the JFET gate resistance is R_{JG_OFF} during the turn-off process, and R_{GJ_OFF} can be used to effectively control turn-off speed. After the device is fully off, CLAMPDRV is changed to high level, which turns the MOSFET M2 on.

In the off-state, CLAMPDRV is high and the clamp MOSFET M2 is in on-state. The effective JFET gate resistance is equal to the parallel combination of R_{JG_OFF} and R_{JG_ON} . R_{JG_ON} can be selected small enough to prevent the reverse recovery issue. During the turn-on transient, the JFET gate current may flow from the cascode source through the body diode of the MOSFET M2 and R_{JG_ON} into the JFET gate, so, the turn-on process is also determined by R_{JG_ON} .

In summary, the optimum switching performance of the SiC cascode FETs can be realized with the ClampDRIVE method by selecting proper JFET gate resistors R_{JG_ON} and R_{JG_OFF} .

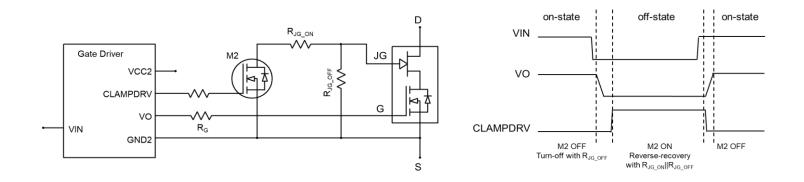


Figure A. Circuit schematic and timing diagram of the ClampDRIVE method





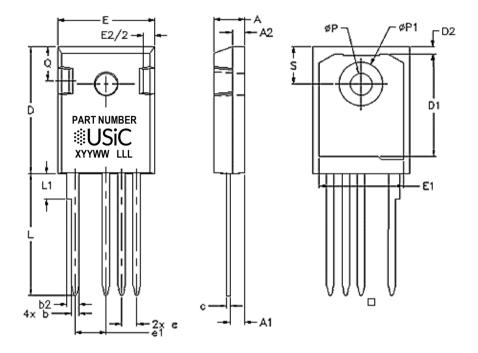
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TO-247-4L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS

PACKAGE OUTLINE



DIM	INC	HES	MILLIMETERS		
	MIN	MAX	MIN	MAX	
A	0.185	0.209	4.7	5.31	
A1	0.087	0.102	2.21	2.59	
A2	0.059	0.098	1.5	2.49	
b	0.039	0.055	0.99	1.4	
b2	0.065	0.094	1.65	2.39	
С	0.015	0.035	0.38	0.89	
D	0.819	0.845	20.8	21.46	
D1	0.515	-	13.08	-	
D2	0.02	0.053	0.51	1.35	
E	0.61	0.64	15.49	16.26	
e	0.100 BSC		2.54 BSC		
e1	0.19	0.21	4.83	5.33	
E1	0.53	-	13.46	-	
E2	0.14	0.16	3.56	4.06	
L	0.78	0.8	19.81	20.32	
L1	-	0.177	-	4.5	
ФР	0.14	0.144	3.56	3.66	
ΦΡ1	0.278	0.291	7.06	7.39	
Q	0.212	0.244	5.38	6.2	
S	0.243 BSC		6.17 BSC		



TO-247-4L PACKAGE OUTLINE, PART MARKING AND TUBE SPECIFICATIONS

PART NUMBER = REFER TO DS_PN DECODER FOR DETAILS X = ASSEMBLY SITE

YY = YEAR WW = WORK WEEK LLL = LOT ID

PACKING TYPE

ANTI-STATIC TUBE

QUANTITY /TUBE : 30 UNITS

XYYWW

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